

Small IPM (Intelligent Power Module) P633C Series 6MBP**XS*065-50

Application Manual

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Fuji Electric Co., Ltd.

MT6M16945

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The products described in this application manual are manufactured with the intention of being used in the following industrial electronic and electrical devices that require normal reliability.

- Compressor motor inverter
- Fan motor inverter for room air conditioner
- Compressor motor inverter for heat pump applications, etc.

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- •Transportation equipment (mounted on vehicles and ships)
- Trunk communications equipment
- Traffic-signal control equipment
- ·Gas leakage detectors with an auto-shutoff function
- Disaster prevention / security equipment
- ·Safety devices, etc.

Do not use a product in this application note for equipment requiring extremely high reliability such as:

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 Airborne equipment
 Atomic control equipment
- Submarine repeater equipment
 Medical equipment

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Chapter 2 Description of Terminal Symbols and Terminology

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2-1



1. Description of Terminal Symbols

Table 2-1 describes the terminal symbols, and Table 2-2 to 2-6 explain the terminology.

| Table 2-1 Description of Terminal Symbols | ole 2-1 Description of Termina | I Symbols |
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| Pin No. | Pin Name | Pin Description |
|---------|----------|---|
| 3 | VB(U) | High side bias voltage for U-phase IGBT driving |
| 5 | VB(V) | High side bias voltage for V-phase IGBT driving |
| 7 | VB(W) | High side bias voltage for W-phase IGBT driving |
| 9 | IN(HU) | Signal input for high side U-phase |
| 10 | IN(HV) | Signal input for high side V-phase |
| 11 | IN(HW) | Signal input for high side W-phase |
| 12 | VCCH | High side control supply |
| 13 | СОМ | Common supply ground |
| 14 | IN(LU) | Signal input for low side U-phase |
| 15 | IN(LV) | Signal input for low side V-phase |
| 16 | IN(LW) | Signal input for low side W-phase |
| 17 | VCCL | Low side control supply |
| 18 | VFO | Fault output |
| 19 | IS | Over current sensing voltage input |
| 20 | СОМ | Common supply ground |
| 21 | TEMP | Temperature sensor output |
| 22 | N(W) | Negative bus voltage input for W-phase |
| 23 | N(V) | Negative bus voltage input for V-phase |
| 24 | N(U) | Negative bus voltage input for U-phase |
| 26 | W | Motor W-phase output |
| 28 | V | Motor V-phase output |
| 30 | U | Motor U-phase output |
| 32 | Р | Positive bus voltage input |
| 36 | NC | No Connection |



2. Description of Terminology

| Item | Symbol | Description |
|---|----------------------|---|
| Zero gate Voltage Collector current | I _{CE} | Collector current when a specified voltage is applied between the collector and emitter of an IGBT with all input signals L (=0V) |
| Collector-Emitter saturation voltage | V _{CE(sat)} | Collector-emitter voltage at a specified collector current when the input signal of only the element to be measured is H (= $5V$) and the inputs of all other elements are L (= $0V$) |
| Forward voltage | V _F | Forward voltage at a specified forward current with all input signals L (=0V) $$ |
| Turn-on time | t _{on} | The time from the input signal rising above the threshold value until the collector current becomes 90% of the rating. See Fig. 2-1. |
| Turn-on delay time | t _{d(on)} | The time from the input signal rising above the threshold value until the collector current decreases to 10% of the rating. See Fig. 2-1. |
| Turn-on rise time | <i>t</i> r | The time from the collector current becoming 10% at the time of IGBT turn-on until the collector current becomes 90%. See Fig. 2-1. |
| V_{CE} - I_{C} Cross time of turn-on | t _{c(on)} | The time from the collector current becoming 10% at the time of IGBT turn-on until the V_{CE} voltage of IGBT dropping below 10% of the rating. See Fig. 2-1. |
| Turn-off time | t _{off} | The time from the input signal dropping below the threshold value until the V_{CE} voltage of IGBT becomes 90% of the rating. See Fig. 2-1. |
| Turn-off delay time | $t_{ m d(off)}$ | The time from the input signal dropping below the threshold value until the collector current decreases to 90%. See Fig. 2-1. |
| Turn-on fall time | t _f | The time from the collector current becoming 90% at the time of IGBT turn-off until the collector current decreases to 10%. See Fig. 2-1. |
| V_{CE} - I_{C} Cross time of turn-off | $t_{\rm c(off)}$ | The time from the V_{CE} voltage becoming 10% at the time of IGBT turn-off until the collector current dropping below 10% of the rating. See Fig. 2-1. |
| Reverse Recovery time | t _{rr} | The time required for the reverse recovery current of the built- in diode to disappear. See Fig. 2-1. |

Table 2-3 Description of Terminology(Control circuit block)

| • | | / |
|--|-------------------|---|
| Item | Symbol | Description |
| Circuit current of Low-side drive IC | I _{CCL} | Current flowing between control power supply $V_{\mbox{\scriptsize CCL}}$ and COM |
| Circuit current of High-side drive IC | I _{ссн} | Current flowing between control power supply $V_{\mbox{\scriptsize CCH}}$ and COM |
| Circuit current of Bootstrap circuit | I _{ССНВ} | Current flowing between upper side IGBT bias voltage supply VB(U) and U,VB(V) and V or VB(W) and W on the P-side (per one unit) |



Table 2-3 (Continued)

| Item | Symbol | Description |
|---|------------------------|---|
| Input Cignal threahold valtage | V _{th(on)} | Control signal voltage when IGBT changes from OFF to ON |
| Input Signal threshold voltage | $V_{\mathrm{th(off)}}$ | Control signal voltage when IGBT changes from ON to OFF |
| Input Signal threshold hysteresis voltage | $V_{ m th(hys)}$ | The hysteresis voltage between $V_{\text{th(on)}}$ and $V_{\text{th(off)}}$. |
| Operational input pulse width of turn-on | t _{IN(ON)} | Control signal pulse width necessary to change IGBT from OFF to ON. Refer to Chapter 3 section 4. |
| Operational input pulse width of turn-off | t _{IN(OFF)} | Control signal pulse width necessary to change IGBT from ON to OFF. Refer to Chapter 3 section 4. |
| Input current | I _{IN} | Current flowing between signal input IN(HU,HV,HW,LU,LV,LW) and COM. |
| Input pull-down resistance | R _{IN} | Resistance of resistor connected between each input terminals IN(HU,HV,HW,LU,LV,LW) and COM. |
| Fault Output voltage | $V_{\rm FO(H)}$ | Output voltage level of VFO terminal under the normal operation (The low-side arm protection function is not actuated.) with pull- up resistor 10kW. |
| | V _{FO(L)} | Output voltage level of VFO terminal after the low-side arm protection function is actuated. |
| Fault Output pulse width | t _{FO} | Period in which an fault status continues to be output (V_{FO}) from the VFO terminal after the low-side arm protection function is actuated. Refer to Chapter 3 section 6. |
| Over Current Protection voltage level | V _{IS(ref)} | Threshold voltage of IS terminal at the over current protection. Refer to Chapter 3 section 5. |
| Over Current Protection delay time | $t_{\rm d(IS)}$ | The time from the Over current protection triggered until the collector current becomes 50% of the rating. Refer to Chapter 3 section 5. |
| Output Voltage of temperature sensor | V _(temp) | The output voltage of temp. It is applied to the temperature sensor output model. Refer to Chapter 3 section 7. |
| LVIC overheating protection | Т _{ОН} | Tripping temperature of overheating protection. The temperature is monitored by LVIC. All low side IGBTs are shut down when the LVIC temperature exceeds T_{OH} . See Fig.2-2 and refer to Chapter 3 section 8. |
| LVIC overheating protection hysteresis | T _{OH(hys)} | Hysteresis temperature that does not reset the overheating protection operation. See Fig.2-2 and refer to Chapter 3 section 8. T_{OH} and $T_{OH(hys)}$ are applied to the overheating protection model. |
| V _{CC} Under Voltage Trip Level of Low-side | V _{CCL(OFF)} | Tripping voltage of the low-side control IC power supply. All low side IGBTs are shut down when the voltage of V_{CCL} drops below this threshold. Refer to Chapter 3 section 1. |
| V _{CC} under voltage reset level of Low-side | V _{CCL(ON)} | Resetting threshold voltage from under voltage trip status of V_{CCL} . Refer to Chapter 3 section 1. |
| V _{CC} under voltage hysteresis of Low-side | V _{CCL(hys)} | Hysteresis voltage between $V_{CCL(OFF)}$ and $V_{CCL(ON)}$. |



Table 2-3 (Continued)

| Item | Symbol | Description |
|---|-----------------------|--|
| V _{CC} Under Voltage Trip Level of High-side | V _{CCH(OFF)} | Tripping voltage of high-side control IC power supply. The IGBTs of high-side are shut down when the voltage of $V_{\rm CCH}$ drops below this threshold. Refer to Chapter 3 section 1. |
| V _{CC} Under Voltage Reset Level of High-side | V _{CCH(ON)} | Resetting threshold voltage from under voltage trip status of V_{CCH} . See Fig.3-3 Resetting voltage at which the IGBT performs shut down when the high-side control power supply voltage V_{CCH} drops. Refer to Chapter 3 section 1. |
| V _{CC} Under Voltage hysteresis of High-side | V _{CCH(hys)} | Hysteresis voltage between $V_{CCH(OFF)}$ and $V_{CCH(ON)}$. |
| V _B Under Voltage Trip Level | $V_{B(OFF)}$ | Tripping voltage $V_{\rm B}(^*)$ under voltage. The high-side IGBTs are shut down when the voltage of $V_{\rm B}(^*)$ drops below this threshold. Refer chapter 3 section 2. |
| V _B Under Voltage Reset Level | V _{B(ON)} | Resetting voltage at which the IGBT performs shut down when the upper side arm IGBT bias voltage $V_{\rm B}(^*)$ drops. Refer to Chapter 3 section 2. |
| $V_{\rm B}$ Under Voltage hysteresis | V _{B(hys)} | Hysteresis voltage between $V_{B(OFF)}$ and $V_{B(ON)}$. |
| Forward voltage of Bootstrap diode | V _{F(BSD)} | Forward voltage when a specified forward current flows through BSD. |
| Built-in limiting Series Resistance (BSD) | $R_{S(BSD)}$ | Built-in current limiting resistor resistance value of bootstrap circuit. |

1: $V_{B()}$ is applied between VB(U)-U, VB(V)-V, VB(W)-W.

Table 2-5 Thermal Characteristics

| Item | Symbol | Description |
|---|---------------------------------------|--|
| Junction to Case Thermal Resistance (per single IGBT) | R _{th(j-c)_IGBT} | Thermal resistance from the junction to the case of a single IGBT. |
| Junction to Case Thermal Resistance (per single FWD) | $R_{\mathrm{th(j-c)}_{\mathrm{FWD}}}$ | Thermal resistance from the junction to the case of a single FWD. |

Table 2-6 Mechanical Characteristics

| Item | Symbol | Description |
|------------------------------|--------|--|
| Mounting torque of screws | Ms | Screwing torque when mounting the Small IPM to a heat sink with a specified screw. |
| Heat-sink side flatness | - | Flatness of a heat sink side. See Fig.2-3. |
| Weight | - | Weight of this product |
| Resistance to soldering heat | - | Soldering heat resistance |



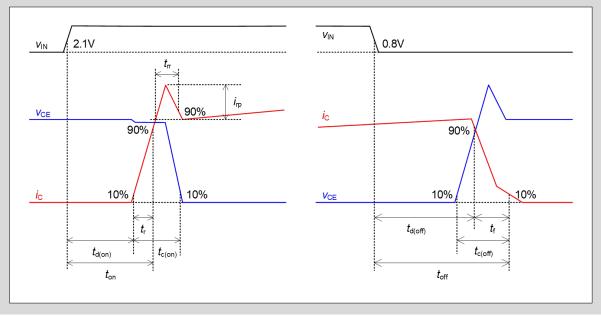


Fig.2-1 Switching waveforms

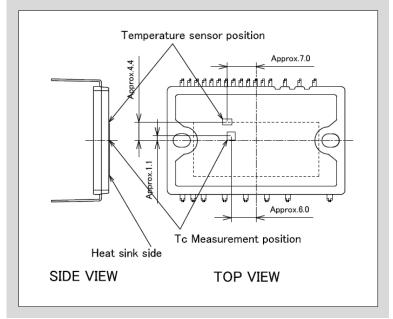


Fig.2-2 The measurement position of temperature sensor and Tc.



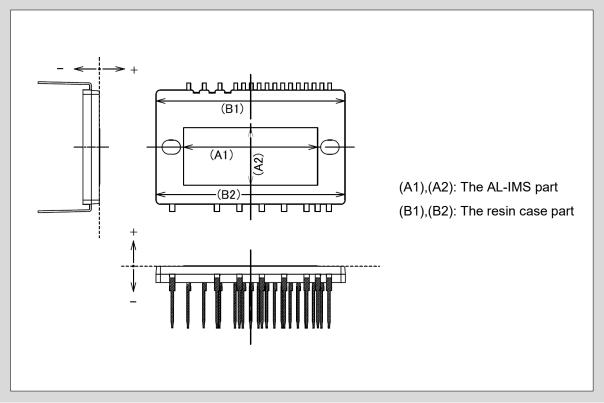


Fig.2-3 The measurement point of heat-sink side flatness.